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Edward; 17212 Quail Court, Morgan Hill, CA 95037 (US).  
MARGULIES, David, Thomas; 10610C New Avenue,  
Gilroy, CA 95020 (US).

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(74) Agent: **BURT, Roger, James; IBM United Kingdom Limited, Intellectual Property Law, Hursley Park, Winchester, Hampshire SO21 2JN (GB).**

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(71) Applicant: **INTERNATIONAL BUSINESS MACHINES CORPORATION [US/US];** New Orchard Road, Armonk, NY 10504 (US).

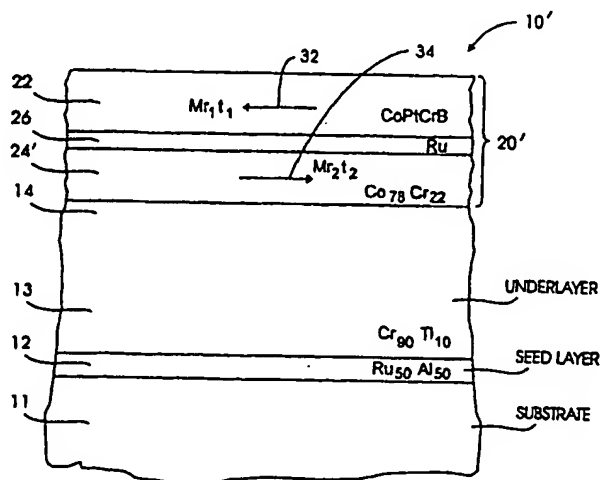
(71) Applicant (*for MG only*): **IBM UNITED KINGDOM LIMITED [GB/GB];** P.O. Box 41, North Harbour, Portsmouth, Hampshire PO6 3AU (GB).

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(72) Inventors: **DOERNER, Mary, Frances; 148 Forest Avenue, Santa Cruz, CA 95062 (US). FULLERTON, Eric,**

[Continued on next page]

(54) Title: **ANTIFERROMAGNETICALLY COUPLED MAGNETIC RECORDING MEDIA**



(57) Abstract: A magnetic recording medium for data storage uses a magnetic recording layer having at least two ferromagnetic films exchange coupled together antiferromagnetically across a nonferromagnetic spacer film. In this antiferromagnetically-coupled (AFC) recording layer the magnetic moments of the two ferromagnetic films are oriented antiparallel, and thus the net remanent magnetization-thickness product ( $Mrt$ ) of the AFC recording layer is the difference in the  $Mrt$  values of the two ferromagnetic films. This reduction in  $Mrt$  is accomplished without a reduction in thermal stability of the recording medium. The lower ferromagnetic film in the AFC recording layer is a boron-free ferromagnetic CoCr alloy that does not require a nucleation layer between it and the Cr alloy underlayer. The ferromagnetic CoCr alloy has sufficient saturation magnetization ( $M_s$ ) to produce excellent magnetic recording performance for the AFC recording layer, while also serving as a template or nucleation layer to induce the growth of the spacer layer and top ferromagnetic boron-containing ferromagnetic film.

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## ANTIFERROMAGNETICALLY COUPLED MAGNETIC RECORDING MEDIA

Technical Field

5 This invention relates generally to magnetic recording media, and more particularly to a magnetic recording disk with an antiferromagnetically-coupled (AFC) magnetic recording layer of the type described in the above-cited co-pending application.

10 Background of the Invention

Conventional magnetic recording media, such as the magnetic recording disks in hard disk drives, typically use a granular ferromagnetic layer, such as a sputter-deposited cobalt-platinum (CoPt) alloy, as the recording medium. Each magnetized domain in the magnetic layer is comprised of many small magnetic grains. The transitions between magnetized domains represent the "bits" of the recorded data. IBM's US patents 4,789,598 and 5,523,173 describe this type of conventional rigid disk.

20 As the storage density of magnetic recording disks has increased, the product of the remanent magnetization  $M_r$  (where  $M_r$  is measured in units of magnetic moment per unit volume of ferromagnetic material) and the magnetic layer thickness  $t$  has decreased. Similarly, the coercive field or coercivity ( $H_c$ ) of the magnetic layer has increased. This has led to a decrease in the ratio  $M_r t / H_c$ . To achieve the reduction in  $M_r t$ , the thickness  $t$  of the magnetic layer can be reduced, but only to a limit because the stored magnetic information in the layer will be more likely to decay. This decay of the magnetization has been attributed to thermal activation of small magnetic grains (the superparamagnetic effect). The thermal stability of a magnetic grain is to a large extent determined by  $K_u V$ , where  $K_u$  is the magnetic anisotropy constant of the layer and  $V$  is the volume of the magnetic grain. As the layer thickness is decreased,  $V$  decreases. If the layer thickness is too thin, the stored magnetic information will no longer be stable at normal disk drive operating conditions.

30 One approach to the solution of this problem is to move to a higher anisotropy material (higher  $K_u$ ). However, the increase in  $K_u$  is limited by the point where the coercivity  $H_c$ , which is approximately equal to  $K_u / M_s$  ( $M_s$  = saturation magnetization), becomes too great to be written by a conventional recording head. A similar approach is to reduce the  $M_s$  of the

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magnetic layer for a fixed layer thickness, which will reduce  $M_r$  since  $M_r$  is related to  $M_s$ , but this is also limited by the coercivity that can be written. Another solution is to increase the intergranular exchange, so that the effective magnetic volume  $V$  of the magnetic grains is increased. However, this approach has been shown to be deleterious to the intrinsic signal-to-noise ratio (SNR) of the magnetic layer.

IBM's Patent Application GB 2355018 describes a magnetic recording medium wherein the magnetic recording layer is at least two ferromagnetic films antiferromagnetically coupled together across a nonferromagnetic spacer film. In this type of magnetic media, referred to as AFC media, the magnetic moments of the two antiferromagnetically-coupled films are oriented antiparallel, with the result that the net remanent magnetization-thickness product ( $M_{rt}$ ) of the recording layer is the difference in the  $M_{rt}$  values of the two ferromagnetic films. This reduction in  $M_{rt}$  is accomplished without a reduction in volume  $V$ . Therefore the thermal stability of the recording medium is not reduced. In one embodiment of the AFC medium the ferromagnetic films are sputter deposited CoPtCrB alloy films separated by a Ru spacer film that has a thickness to maximize the antiferromagnetic coupling between the two CoPtCrB films. One of the ferromagnetic films is made thicker than the other, but the thicknesses are chosen so that the net moment in zero applied magnetic field is low, but nonzero.

AFC media is to be distinguished from conventional "laminated" media, wherein two or more magnetic layers are spaced apart by a nonmagnetic spacer layer so that the magnetic layers are deliberately magnetically decoupled. It is known that substantially improved SNR can be achieved by the use of laminated media. The reduction in intrinsic media noise by lamination is believed due to a decoupling of the magnetic interaction or exchange coupling between the magnetic layers in the laminate. This discovery was made by S. E. Lambert, et al., "Reduction of Media Noise in Thin Film Metal Media by Lamination", *IEEE Transactions on Magnetics*, Vol. 26, No. 5, September 1990, pp. 2706-2709, and subsequently patented in IBM's U.S. patent 5,051,288. IBM's more recent U.S. patent 6,077,586 describes a laminated disk with special seed layers and magnetically decoupled boron-containing ferromagnetic layers.

In general, adding more layers to a disk structure adds complexity to the manufacturing process. Because AFC media require a larger number of sputtering stations due to the larger number of layers that must be sputtered, it may be necessary to substantially modify the existing disk

manufacturing line. In addition, the use of a boron-containing alloy like CoPtCrB in the AFC films, which is necessary for high performance media, requires the use of a special onset or nucleation layer to enhance the growth of the CoPtCrB films so that the C-axis of these films is in the plane of the films. The nucleation layer, which is typically a nonferromagnetic CoCr alloy, requires still another sputtering station in the manufacturing line.

#### Summary of the Invention

Accordingly, the invention provides a magnetic recording disk comprising: a substrate; a nonferromagnetic underlayer selected from the group comprising Cr and alloys of Cr on the substrate; a first ferromagnetic film formed directly on and in contact with the underlayer, the first ferromagnetic film being an alloy comprising cobalt (Co) and chromium (Cr), wherein Cr is between approximately 11 and 25 atomic percent in the alloy; a nonferromagnetic spacer film on the first ferromagnetic film; and a second ferromagnetic film on the spacer film, the second ferromagnetic film being an alloy comprising Co and B, the second ferromagnetic film being exchange coupled antiferromagnetically to the first ferromagnetic film across the spacer film.

According to a preferred embodiment an AFC media is provided that possesses high performance magnetic properties but does not require the addition of sputtering stations to the existing manufacturing line.

An AFC disk is preferably provided wherein the lower ferromagnetic film in the AFC recording layer is a boron-free ferromagnetic CoCr alloy that does not require a nucleation layer between it and the Cr or Cr alloy underlayer. The ferromagnetic CoCr alloy has sufficient saturation magnetization ( $M_s$ ) and grain structure to produce excellent magnetic recording performance for the AFC recording layer, while also serving as a nucleation layer to induce the in-plane C-axis growth of the top boron-containing ferromagnetic film through the spacer layer.

In one embodiment the first ferromagnetic film has a thickness between approximately 1.5 and 3.5 nm.

In one embodiment the underlayer is an alloy of only Cr and titanium (Ti).

In one embodiment a seed layer is provided between the substrate and the underlayer and the underlayer is formed directly on and in contact with the seed layer. By way of example, the seed layer is an alloy of only ruthenium (Ru) and aluminum (Al). Alternatively, the seed layer may be an alloy of only nickel (Ni) and aluminum (Al).

In a preferred embodiment the first ferromagnetic film is an alloy of only Co and Cr. In another embodiment the first ferromagnetic film is an alloy further comprising one or more of platinum (Pt) and tantalum (Ta).

In one embodiment the spacer film consists essentially of ruthenium (Ru) and preferably the second ferromagnetic film is an alloy further comprising Cr and Pt.

By way of example the substrate is glass and in one embodiment there is a protective overcoat formed over the second ferromagnetic film.

In one embodiment the first ferromagnetic film has a thickness  $t_1$  and a magnetization  $M_1$ , the second ferromagnetic film has a thickness  $t_2$  and a magnetization  $M_2$ , and the magnetic moments per unit area ( $M_1 \times t_1$ ) and ( $M_2 \times t_2$ ) of the first and second ferromagnetic films, respectively, are different from one another.

In one embodiment there is a second nonferromagnetic spacer film on the second ferromagnetic film and a third ferromagnetic film on the second spacer film. The third ferromagnetic film is exchange coupled antiferromagnetically to the second ferromagnetic film across the second spacer film.

The invention further provides a magnetic recording disk comprising: a glass substrate; an underlayer selected from the group comprising Cr, a CrV alloy and a CrTi alloy on the substrate; a magnetic recording layer on the underlayer and comprising a first ferromagnetic film of an alloy of only Co and Cr, with Cr being between approximately 11 and 25 atomic percent, formed directly on and in contact with the underlayer, a nonferromagnetic spacer film of a material selected from the group consisting of Ru, Cr, rhodium (Rh), iridium (Ir), copper (Cu), and their alloys formed on the first ferromagnetic film, and a second ferromagnetic film of an alloy comprising Co and B on the spacer film, the spacer film having a thickness sufficient to induce the second ferromagnetic film to be exchange coupled antiferromagnetically to the first ferromagnetic film

across the spacer film; and a protective overcoat formed on the magnetic recording layer.

5 In one embodiment a seed layer is provided between the substrate and the underlayer and the underlayer is an alloy of only Cr and titanium (Ti) and is formed directly on and in contact with the seed layer. By way of example, the seed layer is selected from the group consisting of a RuAl and a NiAl alloy.

10 In one embodiment the spacer film is ruthenium (Ru).

#### Brief Description of the Drawing

15 A preferred embodiment of the present invention will now be described by way of example only and with reference to the following drawings:

20 Fig. 1 is a schematic sectional view of an AFC magnetic recording disk according to the prior art.

Fig. 2 is a schematic sectional view of an AFC magnetic recording disk according to a preferred embodiment of the present invention.

#### Detailed Description of the Invention

25

##### General Structure of an AFC Disk

30 The magnetic recording disk of the preferred embodiment is of the type that has a magnetic recording layer made of two or more ferromagnetic films that are coupled antiferromagnetically (AF) to their neighboring ferromagnetic films by one or more nonferromagnetic spacer films. Fig. 1 illustrates the general cross sectional structure of a disk 10 with an antiferromagnetically-coupled (AFC) magnetic layer 20.

35 The disk substrate 11 is any suitable material, such as glass, SiC/Si, ceramic, quartz, or an AlMg alloy base with a NiP surface coating. The seed layer 12 is an optional layer that may be used to improve the growth of the underlayer 13. The seed layer 12 is most commonly used when the substrate 11 is nonmetallic, such as glass. The seed layer 12 has a  
40 thickness in the range of approximately 1 to 50 nm and is one of the materials, such as Ta, CrTi, NiAl or RuAl, which are useful as seed materials for promoting the growth of subsequently deposited layers in

certain preferred crystalline orientations. A pre-seed layer (not shown) may also be used between the glass substrate 11 and the seed layer 12. The underlayer 13 is deposited onto the seed layer, if present, or otherwise directly onto the substrate 11, and is a nonmagnetic material such as chromium or a chromium alloy, such as CrV or CrTi. The underlayer 13 has a thickness in the range of 5 to 100 nm with a typical value being approximately 10 nm.

The AFC magnetic layer 20 is made up of two ferromagnetic films 22, 24 separated by a nonferromagnetic spacer film 26. The nonferromagnetic spacer film 26 thickness and composition are chosen so that the magnetic moments 32, 34 of adjacent films 22, 24, respectively, are AF-coupled through the nonferromagnetic spacer film 26 and are antiparallel in zero applied field. The two AF-coupled films 22, 24 of layer 20 have magnetic moments that are oriented antiparallel, with the upper film 22 having a larger moment. The ferromagnetic films 22, 24 are made of a CoPtCrB alloy with 4 to 20 atomic percent (at.%) platinum, 10 to 23 at.% chromium and 2 to 20 at.% boron. The nonferromagnetic spacer film 26 is ruthenium (Ru).

Because the first ferromagnetic film 24 of the AFC magnetic layer 20 is a boron-containing CoPtCrB alloy, a very thin (typically 1 to 5 nm) Co alloy onset or nucleation layer 14 is deposited on the underlayer 13. The nucleation layer 14 has a composition selected to enhance the growth of the hexagonal close-packed (HCP) CoPtCrB alloy of film 24 so that its C-axis is oriented in the plane of the film. The proper crystalline structure of the first CoPtCrB film 24 in turn enhances the growth of the second CoPtCrB film 22, through the Ru spacer film 26, to also have its C-axis in-plane. If the CoPtCrB film 24 were grown directly on the Cr alloy underlayer 13 without a nucleation layer, then it would not grow with its C-axis in the plane of the film, which would result in poor recording performance. It is well known that the presence of boron is important for achieving small grains in the recording layer, which is necessary for high performance media. Therefore, the nucleation layer 14 allows use of boron-containing alloys as the recording layer. The nucleation layer 14 typically is a nonferromagnetic Co alloy, and in the preferred embodiment is a CoCr alloy with Cr  $\geq$  31 atomic percent (at%). This CoCr composition produces a phase which is nonferromagnetic or slightly ferromagnetic.

The AF coupling of ferromagnetic films via a nonferromagnetic transition metal spacer film, like the structure of layer 20 in Fig. 1, has been extensively studied and described in the literature. In general,



the exchange coupling oscillates from ferromagnetic to antiferromagnetic with increasing spacer film thickness. This oscillatory coupling relationship for selected material combinations is described by Parkin et al. in "Oscillations in Exchange Coupling and Magnetoresistance in Metallic Superlattice Structures: Co/Ru, Co/Cr and Fe/Cr", *Phys. Rev. Lett.*, Vol. 64, p. 2034 (1990). The material combinations include ferromagnetic films made of Co, Fe, Ni, and their alloys, such as Ni-Fe, Ni-Co, and Fe-Co, and nonferromagnetic spacer films such as Ru, chromium (Cr), rhodium (Rh), iridium (Ir), copper (Cu), and their alloys. For each such material combination, the oscillatory exchange coupling relationship is determined, if not already known, so that the thickness of the nonferromagnetic spacer film is selected to assure antiferromagnetic coupling between the two ferromagnetic films. The period of oscillation depends on the nonferromagnetic spacer material, but the strength and phase of the oscillatory coupling also depends on the ferromagnetic material and interfacial quality.

For this AFC structure of layer 20 the orientations of the magnetic moments 32, 34 of adjacent films 22, 24, respectively, are aligned antiparallel and thus add destructively. The arrows 32, 34 represent the moment orientations of individual magnetic domains that are directly above and below one another across the AF coupling film 26.

While Fig. 1 is shown for an AFC magnetic layer 20 with a two-film structure and a single spacer film, the AFC disk may have additional ferromagnetic films with AF-coupling spacer films between the ferromagnetic films.

Structure according to a preferred embodiment of the present invention of an AFC Disk with a Boron-Free Lower Ferromagnetic Film as a Nucleation Layer

High performance commercially available disks using glass substrates and CoPtCrB single-layer magnetic layers can require of six layers. These layers are a pre-seed layer on the glass substrate (not shown in Fig. 1), the seed layer, the underlayer, the nonferromagnetic (or slightly ferromagnetic) CoCr nucleation layer, the CoPtCrB magnetic layer, and the protective overcoat. Common manufacturing sputtering tools, such as the Circulus M12, currently have only seven stations available for actual sputter deposition, assuming the use of two heating stations and one cooling station. Since the AFC magnetic layer replaces the single magnetic layer with three layers, the total number of sputtering cathodes

needed to create an AFC disk is eight. This number is larger than is currently available on the Circulus M12 configured as described above. Other types of manufacturing sputter tools may also have a limited number of sputtering cathodes, which makes implementation of AFC media difficult.

According to a preferred embodiment, the present invention shows that certain materials can serve the dual purpose of acting as the lower ferromagnetic film in the AFC layer as well as facilitating the in-plane C-axis growth of the second CoPtCrB film through the Ru spacer layer. This allows a combination of the nucleation layer and the lower ferromagnetic film of the AFC layer into one layer and therefore only one sputtering cathode is preferably required. This reduces the total number of sputtered layers in the AFC disk structure, thereby overcoming potential manufacturability problems.

To have a layer that acts as both an onset or nucleation layer and the lower layer in the AFC structure, a material is preferably needed which is a Co-alloy, is able to grow epitaxially on an oriented Cr alloy with its C-axis in the plane of the film, and can perform well as the lower ferromagnetic film in the AFC magnetic recording layer. In the preferred embodiment it has been demonstrated that such a material is ferromagnetic  $\text{Co}_{70}\text{Cr}_{30}$ , which has a saturation magnetization ( $M_s$ ) of 425 emu/cc. X-ray diffraction results showed that for an AFC structure grown on a conventional underlayer, using a  $\text{Co}_{70}\text{Cr}_{30}$  ferromagnetic film directly on the underlayer, a Ru spacer layer directly on the  $\text{Co}_{70}\text{Cr}_{30}$  film, and a CoPtCrB film directly on the Ru spacer layer, the C-axis of the CoPtCrB was in the plane of the film. When a single CoPtCrB film with an Mrt of 0.32 memu/cm<sup>2</sup> was grown directly on a  $\text{Co}_{70}\text{Cr}_{30}$  film with an Mrt of 0.1 memu/cm<sup>2</sup>, the measured Mrt was 0.43 memu/cm<sup>2</sup>, which is very close to the sum of the Mrt of the two layers. When the same type of CoPtCrB film was grown on a Ru layer of the thickness needed to obtain AF coupling, which in turn was grown directly on the same type of  $\text{Co}_{70}\text{Cr}_{30}$  film, the resulting structure had a Mrt of 0.22 memu/cm<sup>2</sup>. This value is the difference of the Mrt values of the two films and shows that AF coupling is present.

It has also been found that the  $\text{CoCr}_x$  alloys with  $14 \leq x \leq 22$  produce excellent magnetic properties when used as the bottom ferromagnetic film in an AFC recording layer. This was not expected since it is known that a minimum concentration of Cr (usually at least 18 at.%) is needed for grain boundary segregation, which in turn is needed to enable independent switching of the magnetization of the grains. Because these CoCr alloys

have a high moment, thinner bottom ferromagnetic films can be used to achieve the desired Mrt. It has been discovered that the thickness of the first ferromagnetic film has a significant effect on the SNR of the resulting AFC structure. Measured SNR for AFC media, all of which had a top ferromagnetic film of  $\text{CoPt}_{12}\text{Cr}_{18}\text{B}_1$ , but in which the lower CoCr ferromagnetic films were of various thicknesses and Cr compositions (Cr between 14 and 20 at.%) have shown that the lower film of CoCr should have a thickness between 1.5 and 3.5 nm to optimize SNR of the AFC media.

In addition, the ratio of the isolated signal pulse to noise ( $S_{\text{NR}}$ ) at 15000 flux reversals/millimeter of recorded transitions in a single layer film, using a conventional nonferromagnetic  $\text{Co}_{99}\text{Cr}_{11}$  nucleation layer, was 29.8 dB, while the  $S_{\text{NR}}$  of an AFC disk using  $\text{Co}_{78}\text{Cr}_{22}$  as the first ferromagnetic film and the same type of CoPtCrB material as the second ferromagnetic film, was 31.3 dB. The isolated pulse width (PW50) for these two disks was 122 nm and 116 nm, respectively. This data shows that the AFC disk with  $\text{Co}_{78}\text{Cr}_{22}$  as the first ferromagnetic film grown directly on the Cr alloy underlayer has high magnetic recording performance.

Fig. 2 shows the preferred structure of the AFC disk 10' according to the invention. The thicknesses and compositions for the various layers in this preferred embodiment are as follows:

Pre-seed layer:  $\text{Al}_{50}\text{Ti}_{50}$  (20-50 nm)  
 Seed Layer 12:  $\text{Ru}_{50}\text{Al}_{50}$  (8-20 nm)  
 Underlayer 13:  $\text{Cr}_{90}\text{Ti}_{10}$  (6-20 nm)  
 Lower AFC Film 24' directly on underlayer 13:  
      $\text{Co}_{(100-x)}\text{Cr}_x$  with  $11 < x < 25$ , or  
      $\text{Co}_{(100-y-x)}\text{Pt}_y\text{Cr}_x$ , with  $0 < y < 15$  and  $11 < x < 25$ , or  
      $\text{Co}_{(100-y-x-z)}\text{Pt}_y\text{Cr}_x\text{Ta}_z$  with  $0 < y < 20$ ,  $11 < x < 22$  and  $2 < z < 6$   
 Spacer Layer 26: Ru or Cr (0.4 - 1.0 nm)  
 Top AFC Film 22:  $\text{Co}_{(100-y-x-z)}\text{Pt}_y\text{Cr}_x\text{B}_z$  with  $6 < y < 25$ ,  $10 < x < 25$ ,  $6 < z < 15$ .

In the preferred embodiment the ferromagnetic CoCr alloy that serves as the bottom AFC film without the need for a special nucleation layer has a composition with Cr between approximately 11 and 25 atomic percent. The Cr concentration is determined primarily by the thickness and Mrt desired for the bottom AFC film. Since the concentration of Cr determines the  $M_s$  of the CoCr alloy, it determines the Mrt of the CoCr film for a given thickness. The desired thickness of the CoCr film is determined by optimum film growth and recording performance. The upper limit is the

amount around which the  $M_s$  of the CoCr alloy is insufficient for high performance recording.

In addition to this preferred binary alloy of only Co and Cr, the lower ferromagnetic film may also be a ternary or quaternary alloy of CoCr with one or more of platinum (Pt) and tantalum (Ta). The Pt may be a desired additive if more anisotropy is desired in the lower film and the Ta may be a desired additive if more grain isolation is desired. The concentrations of  $0 < \text{Pt} < 15$  and  $2 < \text{Ta} < 6$  have been determined to be the typical ranges which have successfully achieved these purposes.

## CLAIMS

1. A magnetic recording disk comprising:

5 a substrate;

a nonferromagnetic underlayer selected from the group comprising Cr and alloys of Cr on the substrate;

10 a first ferromagnetic film formed directly on and in contact with the underlayer, the first ferromagnetic film being an alloy comprising cobalt (Co) and chromium (Cr), wherein Cr is between approximately 11 and 25 atomic percent in the alloy;

15 a nonferromagnetic spacer film on the first ferromagnetic film; and

a second ferromagnetic film on the spacer film, the second ferromagnetic film being an alloy comprising Co and B, the second ferromagnetic film being exchange coupled antiferromagnetically to the first ferromagnetic film across the spacer film.

2. The disk of claim 1 wherein the first ferromagnetic film has a thickness between approximately 1.5 and 3.5 nm.

25 3. The disk of claim 1 or 2 wherein the underlayer is an alloy of only Cr and titanium (Ti).

30 4. The disk of any preceding claim further comprising a seed layer between the substrate and the underlayer and wherein the underlayer is formed directly on and in contact with the seed layer.

5. The disk of claim 4 wherein the seed layer is an alloy of only ruthenium (Ru) and aluminum (Al).

35 6. The disk of claim 4 wherein the seed layer is an alloy of only nickel (Ni) and aluminum (Al).

40 7. The disk of any preceding claim wherein the first ferromagnetic film is an alloy further comprising platinum (Pt).

8. The disk of any preceding claim wherein the first ferromagnetic film is an alloy further comprising tantalum (Ta).

9. The disk of any of claims 1 to 6 wherein the first ferromagnetic film is an alloy of only Co and Cr.

10. The disk of any preceding claim wherein the spacer film consists essentially of ruthenium (Ru).

11. The disk of any preceding claim wherein the second ferromagnetic film is an alloy further comprising Cr and Pt.

12. The disk of any preceding claim wherein the substrate is glass.

13. The disk of any preceding claim further comprising a protective overcoat formed over the second ferromagnetic film.

14. The disk of any preceding claim wherein the first ferromagnetic film has a thickness  $t_1$  and a magnetization  $M_1$ , the second ferromagnetic film has a thickness  $t_2$  and a magnetization  $M_2$ , and wherein the magnetic moments per unit area ( $M_1 \times t_1$ ) and ( $M_2 \times t_2$ ) of the first and second ferromagnetic films, respectively, are different from one another.

15. The disk of any preceding claim further comprising a second nonferromagnetic spacer film on the second ferromagnetic film and a third ferromagnetic film on the second spacer film, the third ferromagnetic film being exchange coupled antiferromagnetically to the second ferromagnetic film across the second spacer film.

16. A magnetic recording disk comprising:

a glass substrate;

an underlayer selected from the group comprising Cr, a CrV alloy and a CrTi alloy on the substrate;

a magnetic recording layer on the underlayer and comprising a first ferromagnetic film of an alloy of only Co and Cr, with Cr being between approximately 11 and 25 atomic percent, formed directly on and in contact with the underlayer, a nonferromagnetic spacer film of a material selected from the group consisting of Ru, Cr, rhodium (Rh), iridium (Ir), copper (Cu), and their alloys formed on the first ferromagnetic film, and a second ferromagnetic film of an alloy comprising Co and B on the spacer film, the spacer film having a thickness sufficient to induce the second

ferromagnetic film to be exchange coupled antiferromagnetically to the first ferromagnetic film across the spacer film; and

a protective overcoat formed on the magnetic recording layer.

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17. The disk of claim 16 wherein the first ferromagnetic film has a thickness between approximately 1.5 and 3.5 nm.

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18. The disk of claim 16 or 17 further comprising a seed layer between the substrate and the underlayer and wherein the underlayer is an alloy of only Cr and titanium (Ti) and is formed directly on and in contact with the seed layer.

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19. The disk of claim 18 wherein the seed layer is selected from the group consisting of a RuAl and a NiAl alloy.

20. The disk of claim 16, 17, 18 or 19 wherein the spacer film is ruthenium (Ru).

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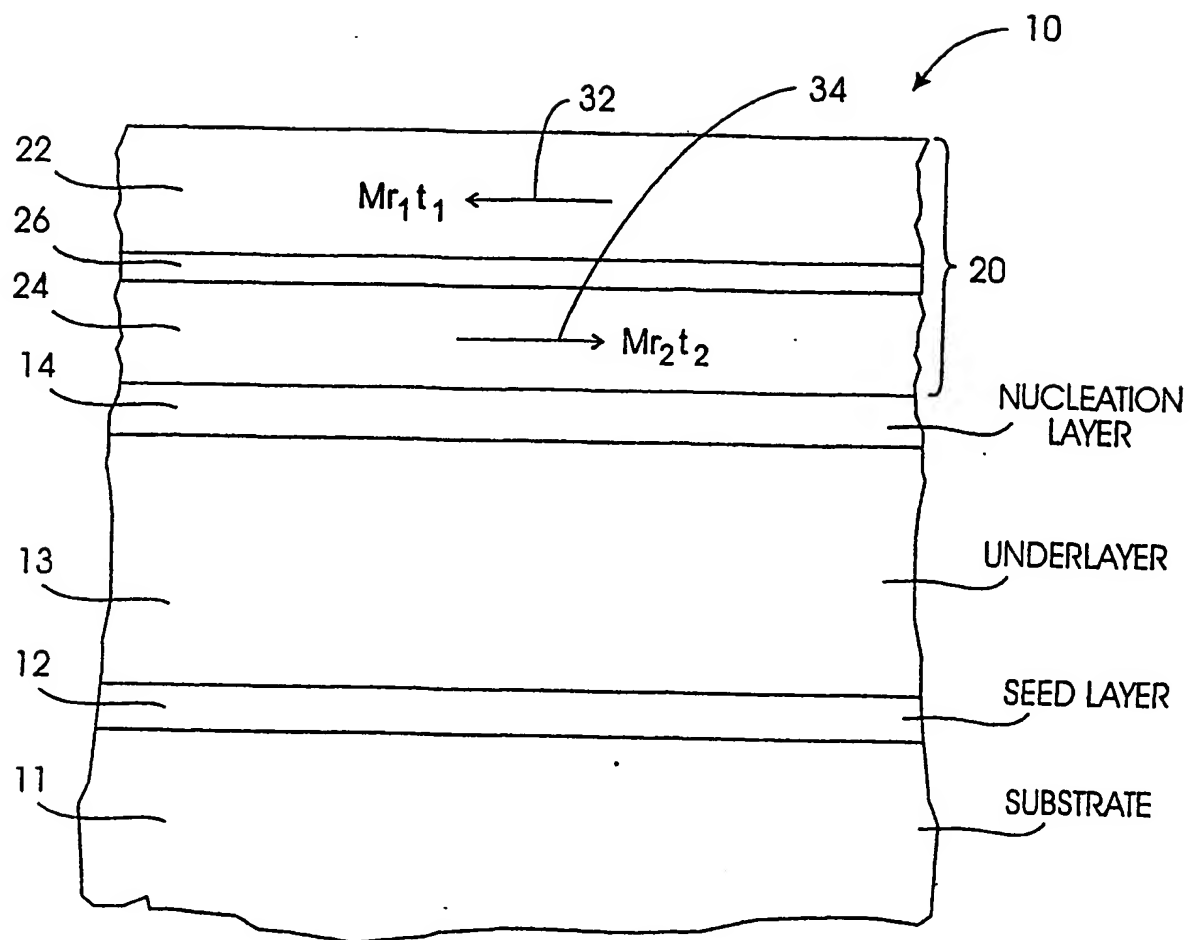


FIG. 1



2/2

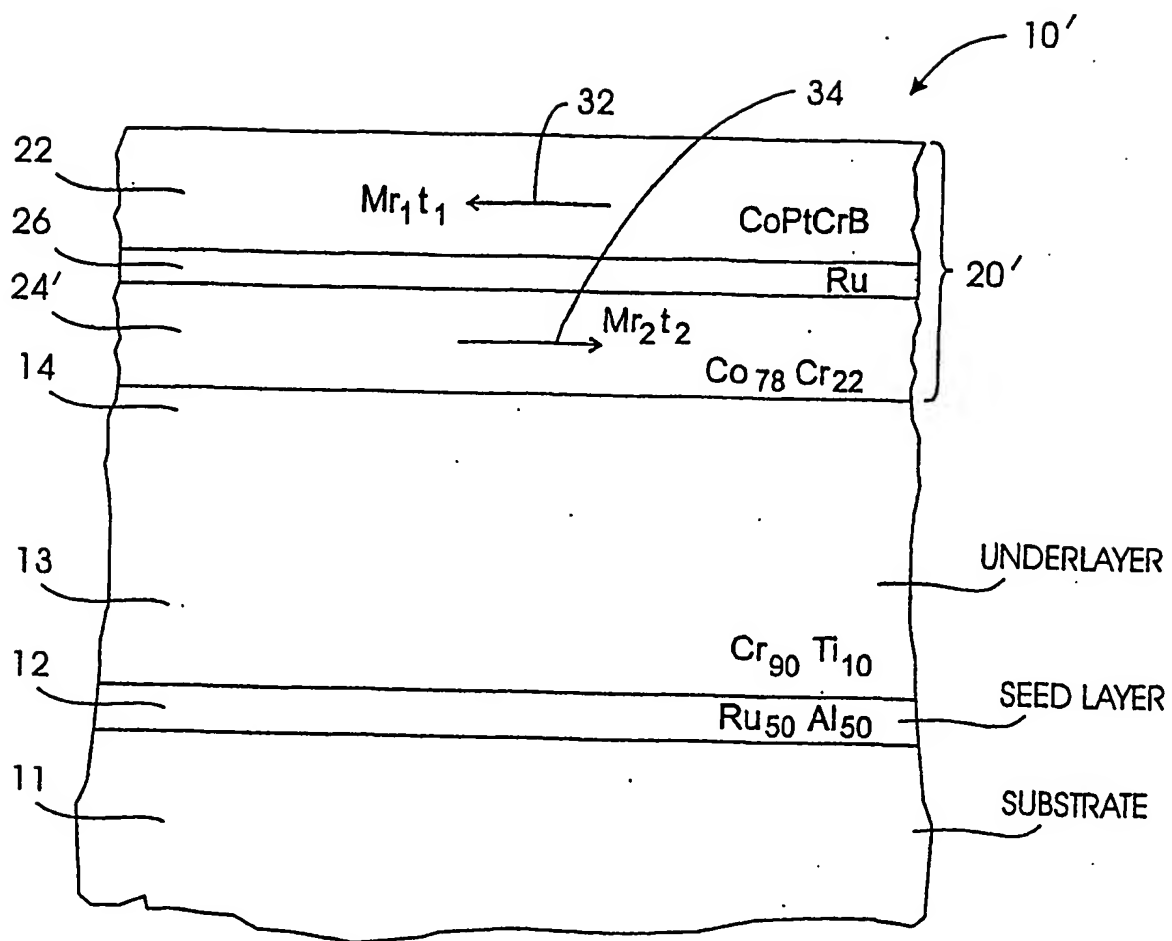


FIG. 2

## INTERNATIONAL SEARCH REPORT

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PC1/GB 01/03302

A. CLASSIFICATION OF SUBJECT MATTER  
IPC 7 G11B5/66

According to International Patent Classification (IPC) or to both national classification and IPC

## B. FIELDS SEARCHED

Minimum documentation searched (classification system followed by classification symbols)  
IPC 7 G11B

Documentation searched other than minimum documentation to the extent that such documents are included in the fields searched

Electronic data base consulted during the international search (name of data base and, where practical, search terms used)

EPO-Internal, PAJ, WPI Data

## C. DOCUMENTS CONSIDERED TO BE RELEVANT

| Category * | Citation of document, with indication, where appropriate, of the relevant passages  | Relevant to claim No.              |
|------------|---|------------------------------------|
| X          | EP 0 892 393 A (IBM)<br>20 January 1999 (1999-01-20)  | 1, 3, 4,<br>6-13, 15,<br>16, 18-20 |
| Y          | column 1, line 26 - line 29<br>column 4, line 25 - line 55<br>column 5, line 39 - line 40<br>column 7, line 12 - line 18; claims 9, 11;<br>figure 2<br>& US 6 077 586 A 20 June 2000 (2000-06-20)<br>cited in the application | 2, 14, 17                          |
| Y          | EP 0 709 830 A (HOYA)<br>1 May 1996 (1996-05-01)<br>page 4, line 37 - line 58<br>page 6, line 53<br>page 10, line 56 - line 59  | 2, 17                              |
| -/-        |   |                                    |

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Date of the actual completion of the international search

28 November 2001

Date of mailing of the international search report

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Name and mailing address of the ISA

European Patent Office, P.B. 5818 Patentlaan 2  
NL - 2280 HV Rijswijk  
Tel (+31-70) 340-2040, Tx 31 651 epo nl,  
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# INTERNATIONAL SEARCH REPORT

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| C.(Continuation) DOCUMENTS CONSIDERED TO BE RELEVANT |  |                       |
|--|--|-----------------------|
| Category *   | Citation of document, with indication, where appropriate, of the relevant passages                           | Relevant to claim No. |
| Y  | US 5 147 732 A (SHIROISHI ET AL.)<br>15 September 1992 (1992-09-15)<br>column 23, line 3 - line 57; figure 3 | 14                    |
| A  | US 5 815 343 A (ISHIKAWA ET AL.)<br>29 September 1998 (1998-09-29)<br>claim 10                               | 5                     |

## INTERNATIONAL SEARCH REPORT

International Application No

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| Patent document<br>cited in search report |   | Publication<br>date | Patent family<br>member(s) | Publication<br>date |
|---|---|---------------------|----------------------------|---------------------|
| EP 892393                                 | A | 20-01-1999          | US 6077586 A               | 20-06-2000          |
|   |   |                     | EP 0892393 A1              | 20-01-1999          |
|   |   |                     | JP 11073621 A              | 16-03-1999          |
|   |   |                     | SG 71130 A1                | 21-03-2000          |
| EP 709830                                 | A | 01-05-1996          | JP 2911783 B2              | 23-06-1999          |
|   |   |                     | JP 9016938 A               | 17-01-1997          |
|   |   |                     | EP 0709830 A2              | 01-05-1996          |
|   |   |                     | JP 8227516 A               | 03-09-1996          |
|   |   |                     | SG 33562 A1                | 18-10-1996          |
|   |   |                     | US 5900324 A               | 04-05-1999          |
|   |   |                     | EP 0718829 A2              | 26-06-1996          |
|   |   |                     | SG 38900 A1                | 17-04-1997          |
|   |   |                     | US 5746893 A               | 05-05-1998          |
| US 5147732                                | A | 15-09-1992          | JP 2168418 A               | 28-06-1990          |
|   |   |                     | JP 2865731 B2              | 08-03-1999          |
| US 5815343                                | A | 29-09-1998          | JP 7037237 A               | 07-02-1995          |
|   |   |                     | JP 7073433 A               | 17-03-1995          |
|   |   |                     | KR 148842 B1               | 15-10-1998          |
|   |   |                     | KR 141381 B1               | 15-07-1998          |